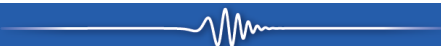


Ultrafast Laser Physics

Matteo Savoini / Lukas Gallmann

ETH Zurich, Physics Department, Switzerland
www.attophys.ethz.ch

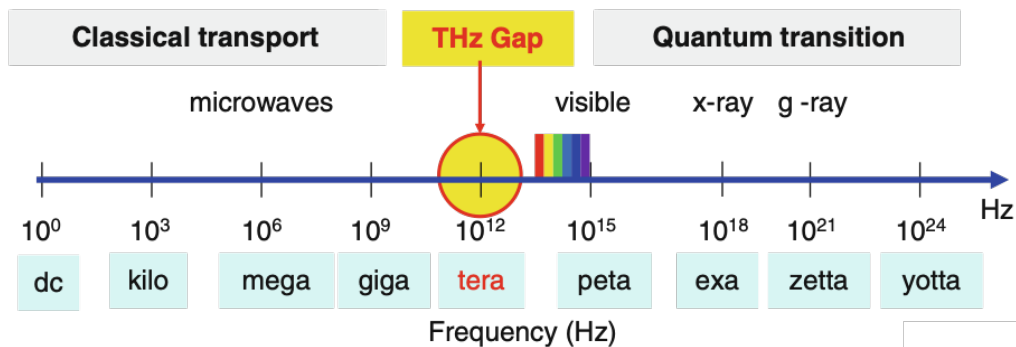
Chapter 14: Ultrafast THz science



- Explain why THz radiation is relevant & its interaction with materials
- Example of applications
- Generation methods
- Detection methods

More in-depth courses on the subject (in case you are interested):

- Terahertz Science and Applications, starting in Fall 2024
- Ultrafast Methods in Solid State Physics, every Spring semester



Frequency: $\nu = 1 \text{ THz} = 1000 \text{ GHz}$
 Angular frequency: $\omega = 2\pi\nu = 6.28 \text{ THz}$
 Period: $\tau = 1/\nu = 1 \text{ ps}$
 Wavelength: $\lambda = c/\nu = 0.3 \text{ mm} = 300 \mu\text{m}$
 Wavenumber: $\bar{k} = k/2\pi = 1/\lambda = 33.3 \text{ cm}^{-1}$
 Photon energy: $h\nu = \hbar\omega = 4.14 \text{ meV}$
 Temperature: $T = h\nu/k_B = 48 \text{ K}$

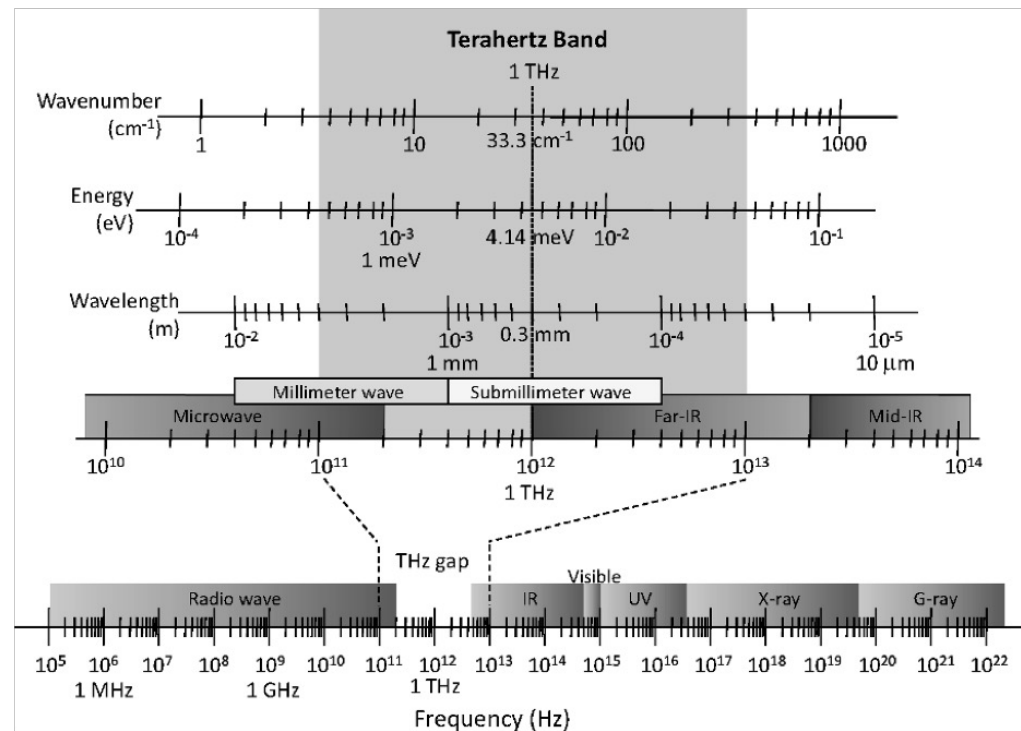
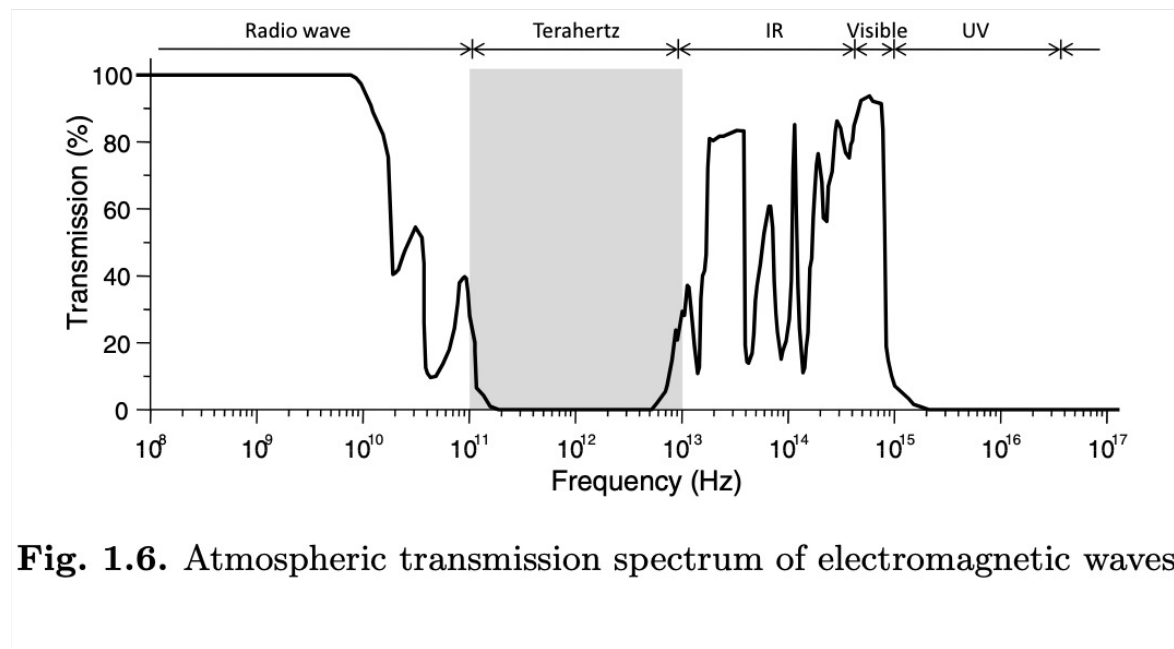


Table 1.1. Optical Properties of Condensed Matter in the THz Band

Material Type	Optical Property
liquid water	high absorption ($\alpha \approx 250 \text{ cm}^{-1}$ at 1 THz)
metal	high reflectivity (>99.5% at 1 THz)
plastic	low absorption ($\alpha < 0.5 \text{ cm}^{-1}$ at 1 THz)
semiconductor	low refractive index ($n \approx 1.5$)
	high refractive index ($n \sim 3-4$)

**Fig. 1.6.** Atmospheric transmission spectrum of electromagnetic waves

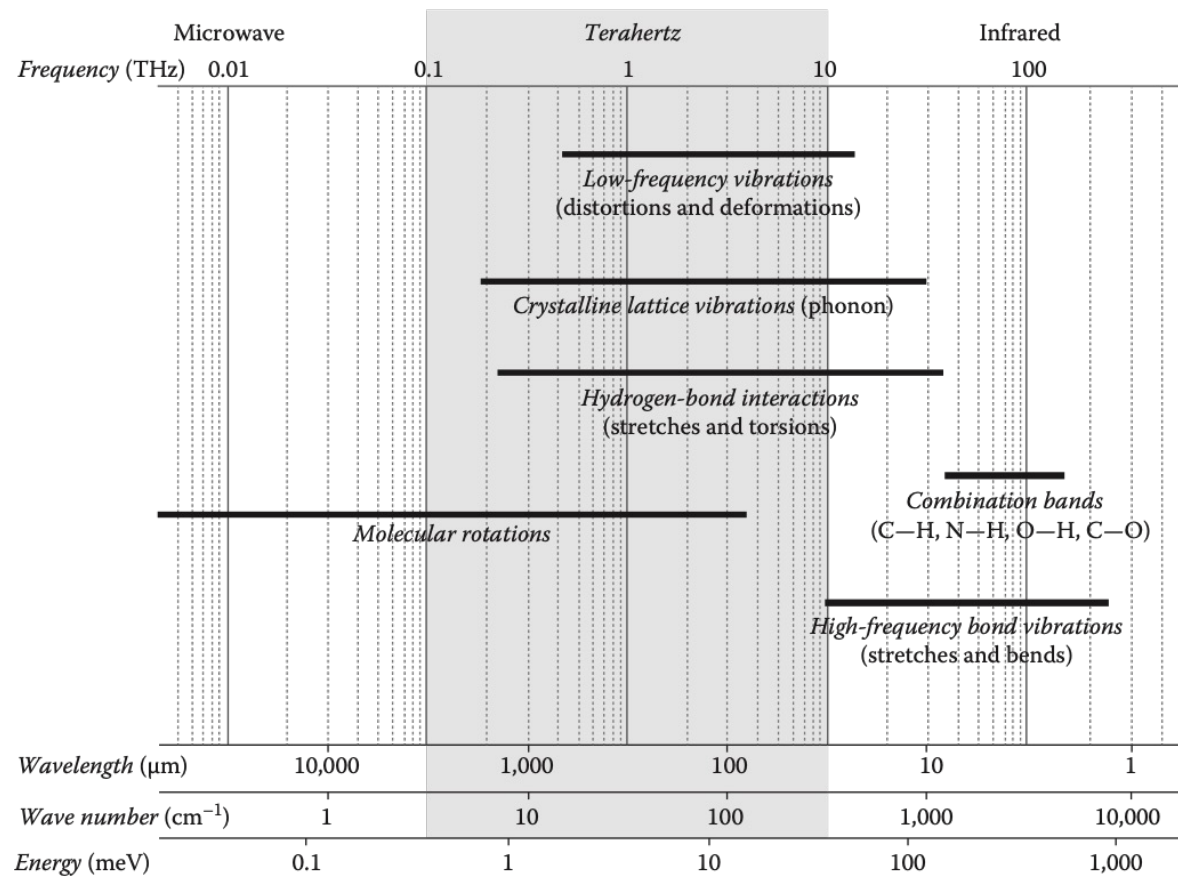
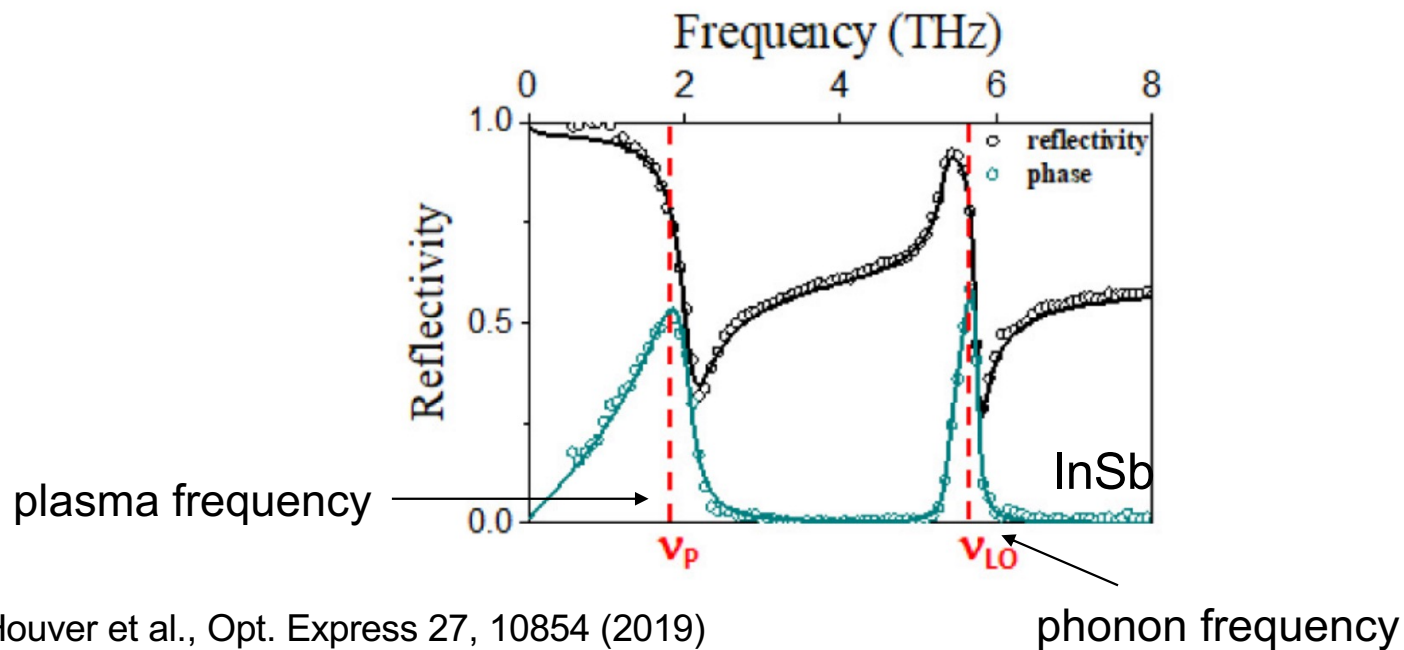


FIGURE 1.1 Characteristic energies in the electromagnetic spectrum around THz frequency region.

Drude model with finite relaxation time

$$\epsilon_r(\omega) = 1 + \frac{\omega_p^2}{\omega_0^2 - \omega^2 - i\omega\gamma} = 1 - \frac{\omega_p^2}{\omega(\omega + i\gamma)}$$

plasma frequency



S. Houver et al., Opt. Express 27, 10854 (2019)

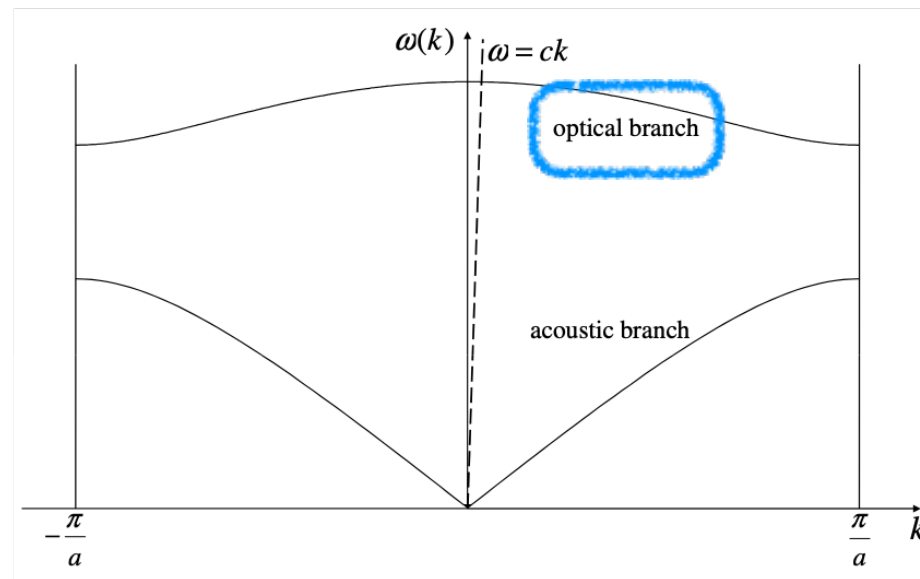
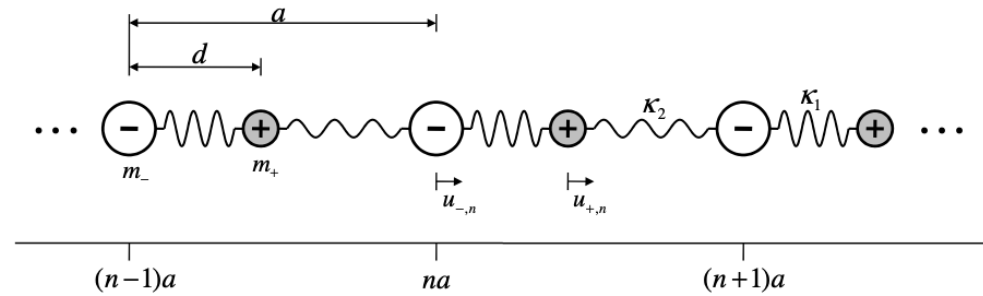
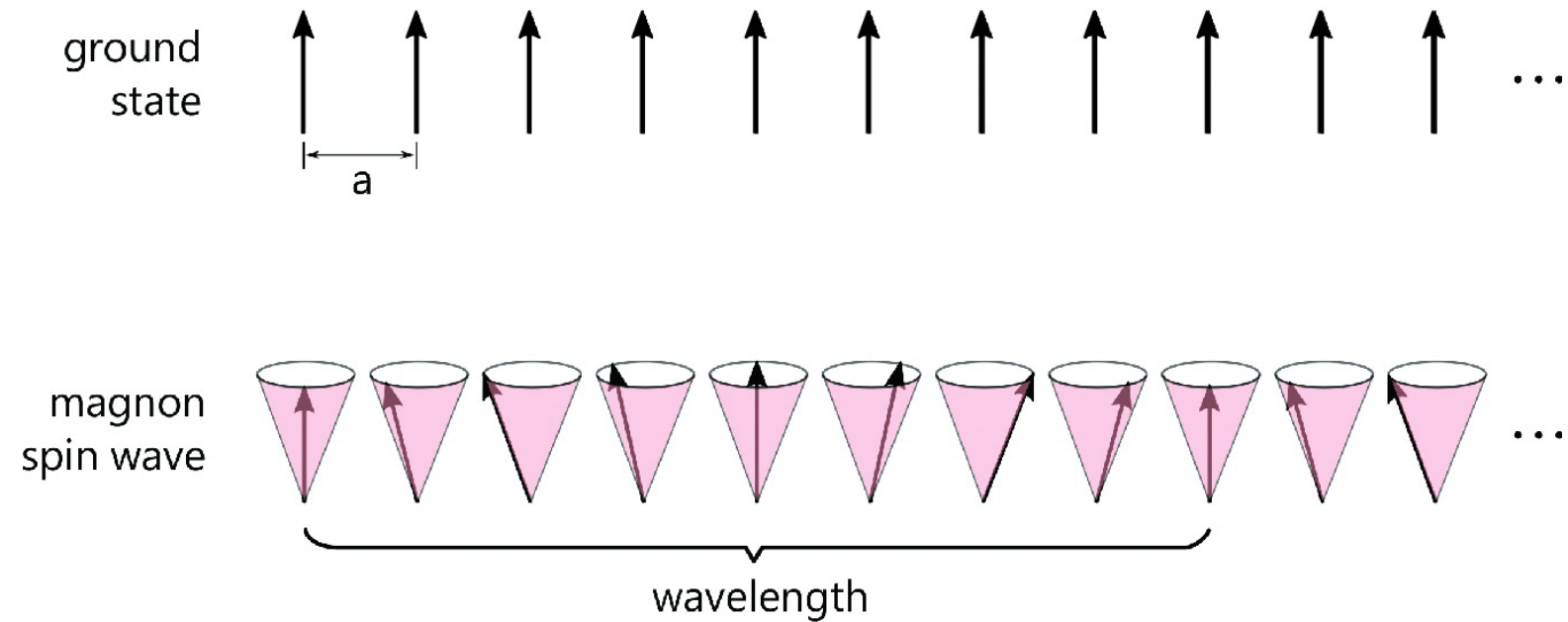
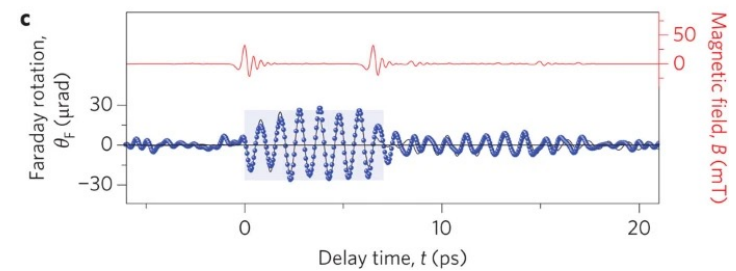
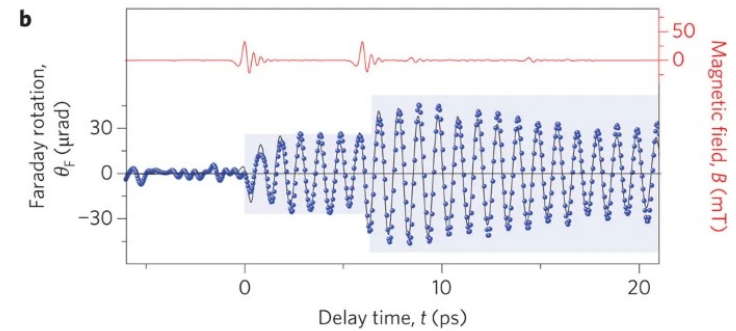
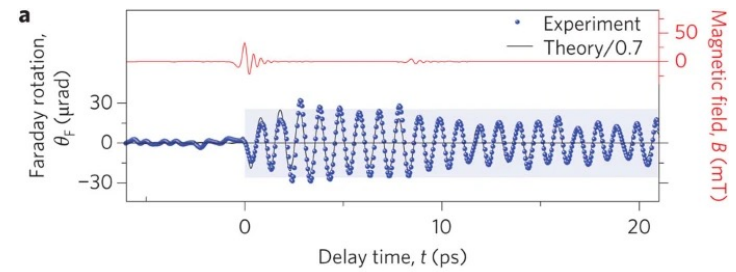
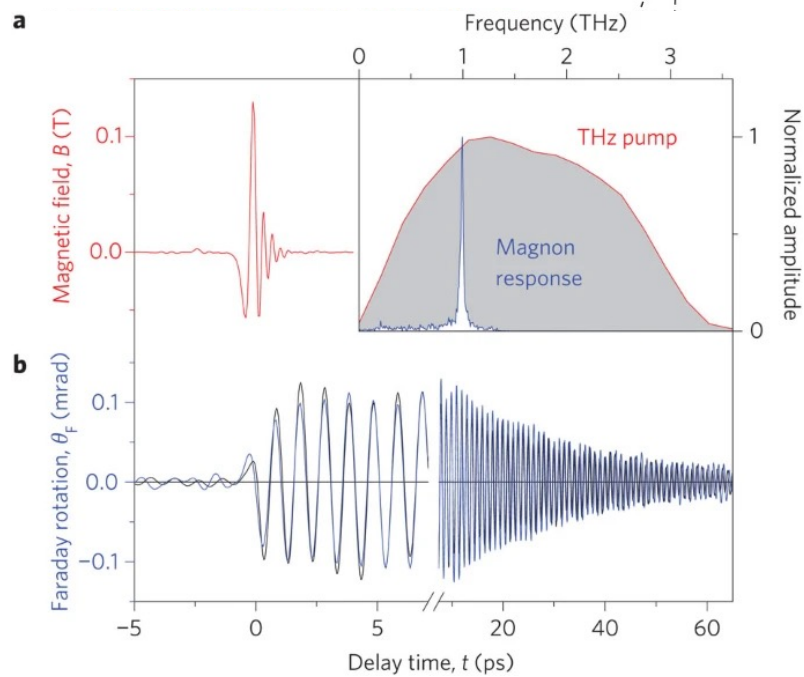
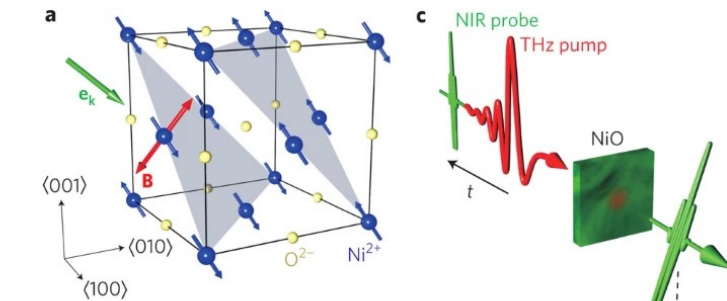


Table 2.1. Transverse Optical Phonon Frequency for Ionic Crystals^a

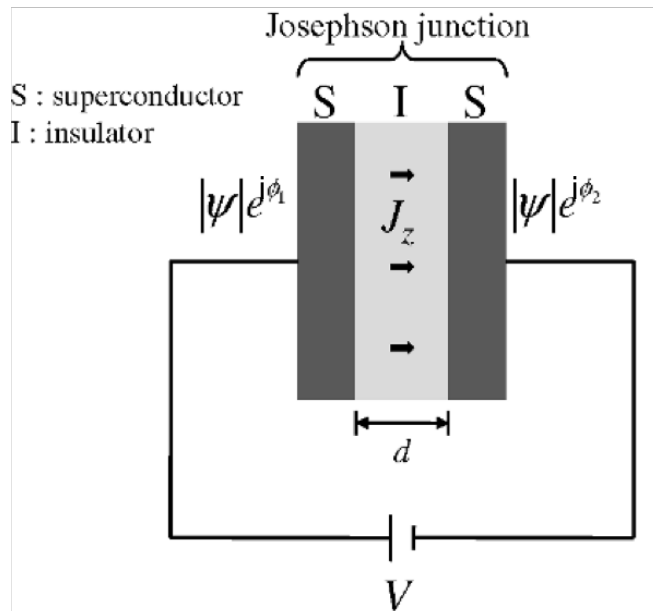
Crystal	$\omega_T/2\pi$ in THz
LiF	9.19
NaF	7.36
KF	5.70
CsF	2.60
LiCl	5.74
NaCl	5.10
KCl	4.47
CsCl	3.14
LiBr	4.76
NaBr	4.06
KBr	3.45
CsBr	2.37

^aReference [11]





Nature Photonics **5**, 31–34(2011)



No bias: $J_z = J_0 \sin \Delta\phi$

$$J_0 \sim \frac{e\hbar}{m^*d} |\psi|^2$$

DC bias: $\Delta\phi = \frac{E_1 - E_2}{\hbar} t = \frac{2eV}{\hbar} t$

(oscillating current)

Oscillating bias:

$$E_z(t) = \frac{V(t)}{d} = E_z^0 e^{-i\omega t}$$

$$\epsilon(\omega) = \epsilon_0 \left[1 - \frac{\omega_{JP}^2}{\omega^2} \right]$$

$$\omega_{JP} = \sqrt{\frac{2eJ_0d}{\hbar\epsilon_0}} \sim \sqrt{\frac{2e^2|\psi|^2}{\epsilon_0 m^*}}$$

Intrinsic Josephson effect in layered cuprate superconductors at THz frequencies: plasma-like absorption below the superconducting transition

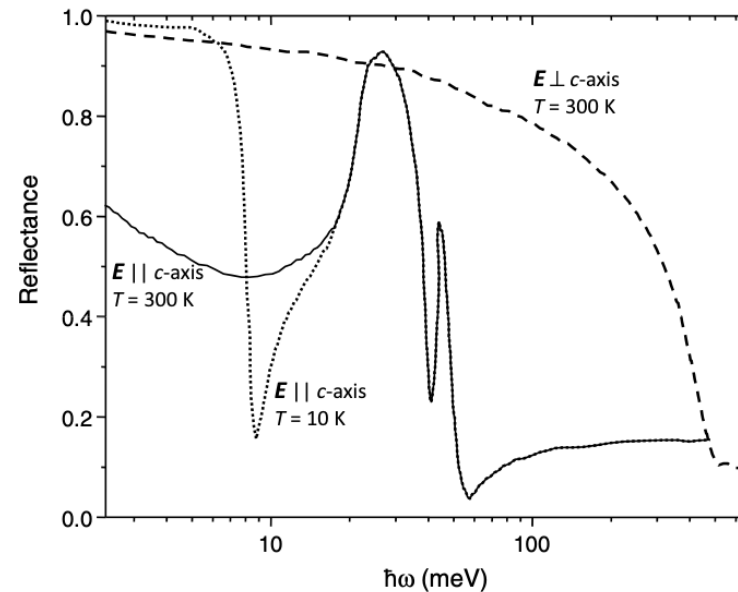
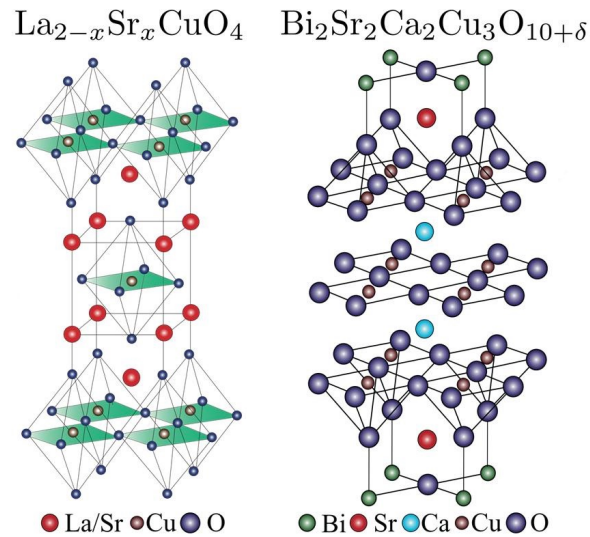
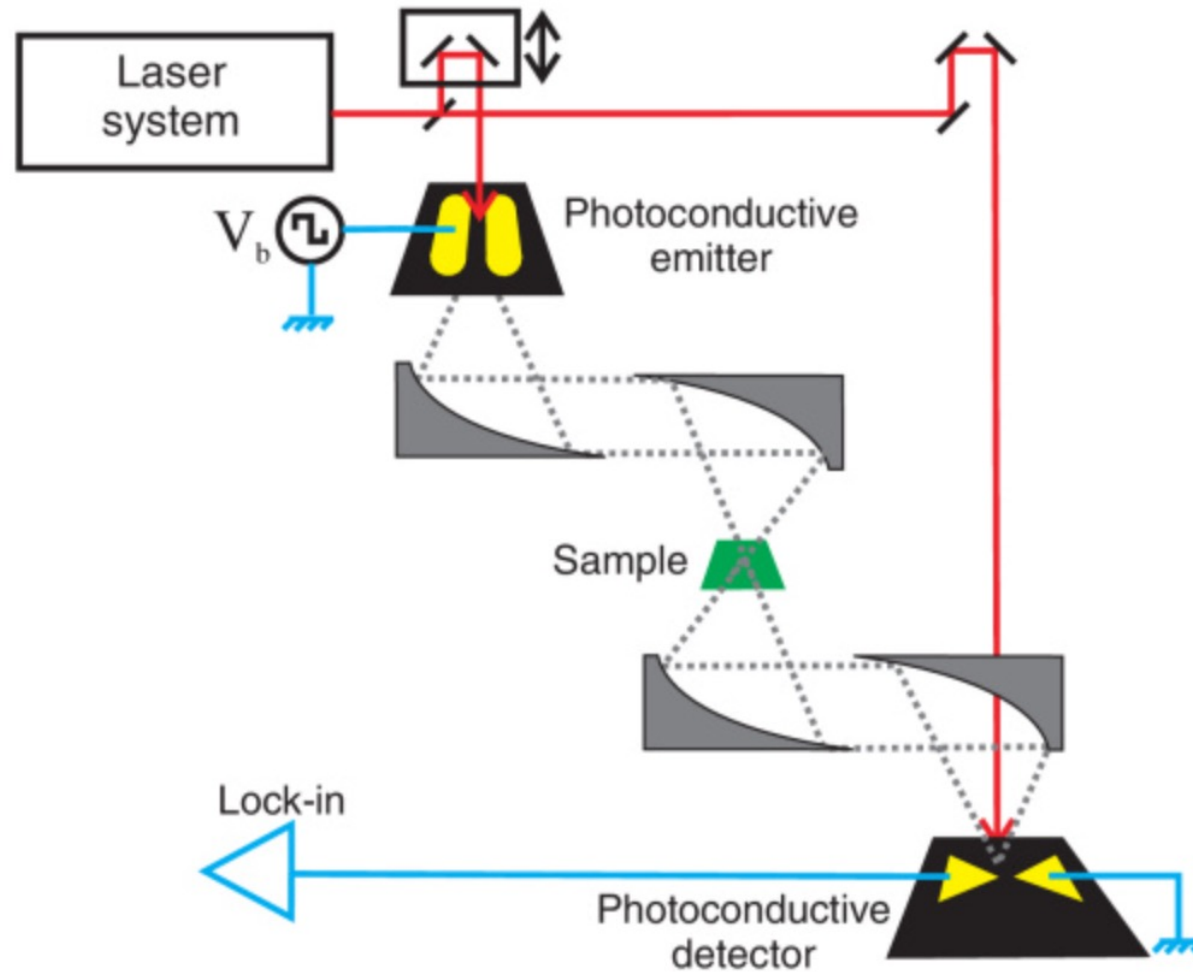


Fig. 8.22. Anisotropic reflectance spectra of a $\text{La}_{1.83}\text{Sr}_{0.17}\text{CuO}_4$ crystal. Dashed line ($T = 300$ K): the field is polarized in the CuO_2 plane ($\mathbf{E} \perp c$ -axis). Solid ($T = 300$ K) and dotted ($T = 10$ K) lines: the field is parallel to the c -axis ($\mathbf{E} \parallel c$ -axis). (Data from Ref. [246])

Generating (coherent) THz-frequency pulses

- Photoconductive Switches
- Optical Rectification in nonlinear crystals
- THz FELs
- Plasma generation



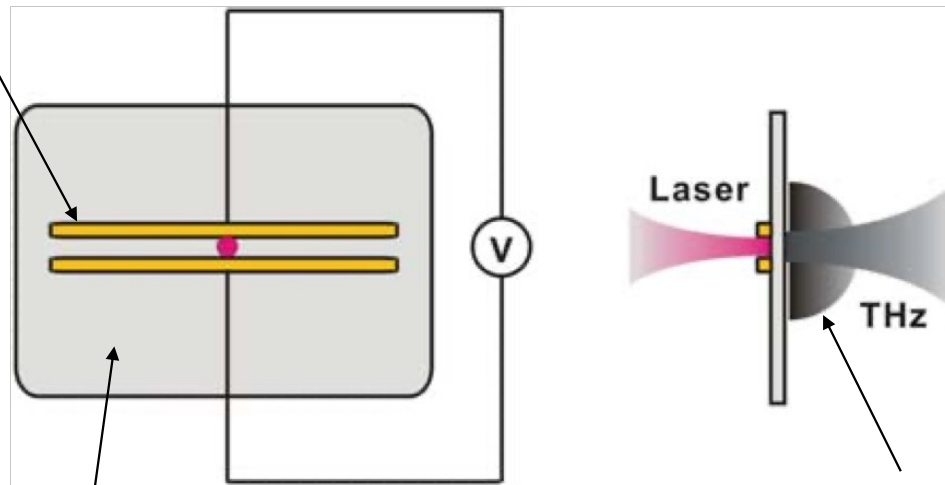


E. Castro-Camus and M. Alfaro, *Photon. Res.* 4, A36-A42 (2016)



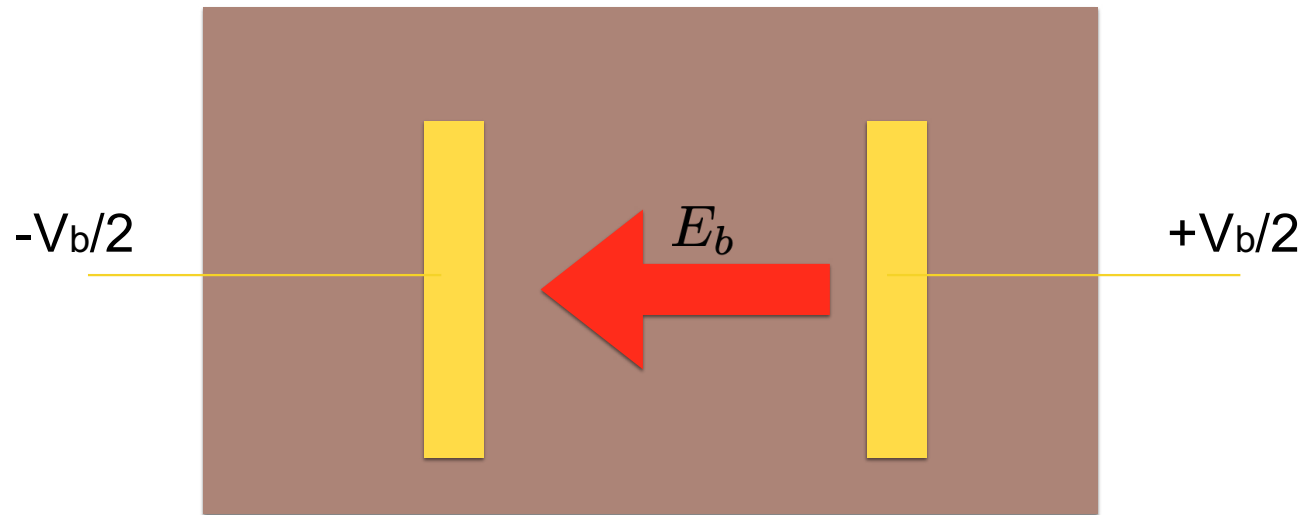
“simple dipolar antenna”

Metal electrodes on surface



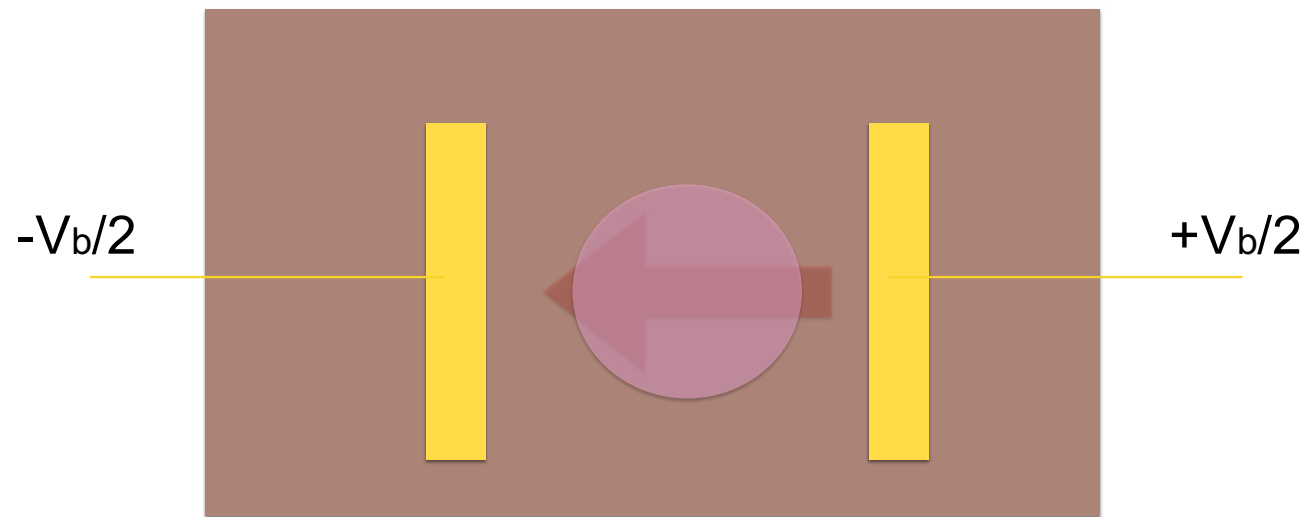
(optional: silicon lens)

Semiconductor substrate, usually “low temperature grown (LT)” GaAs

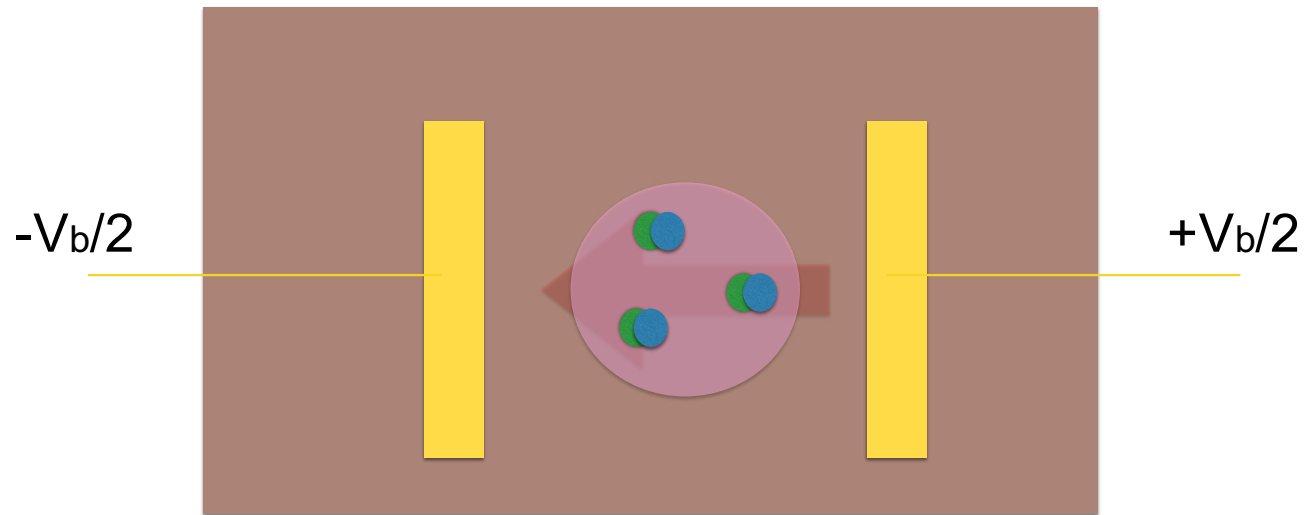


initially, (almost) no electron-hole pairs exist

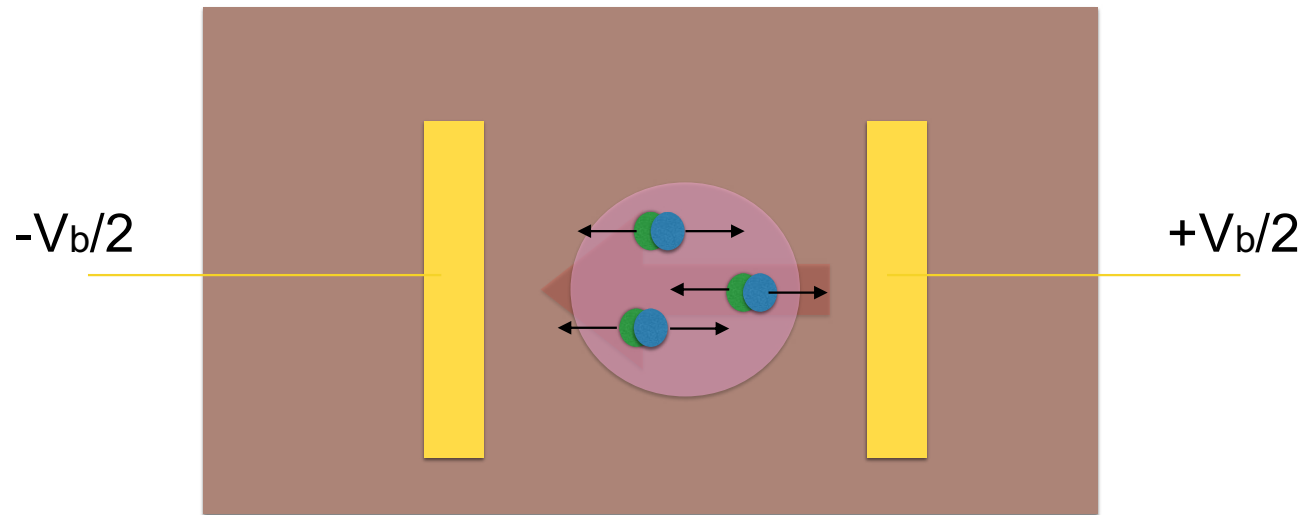
Bias field near surface



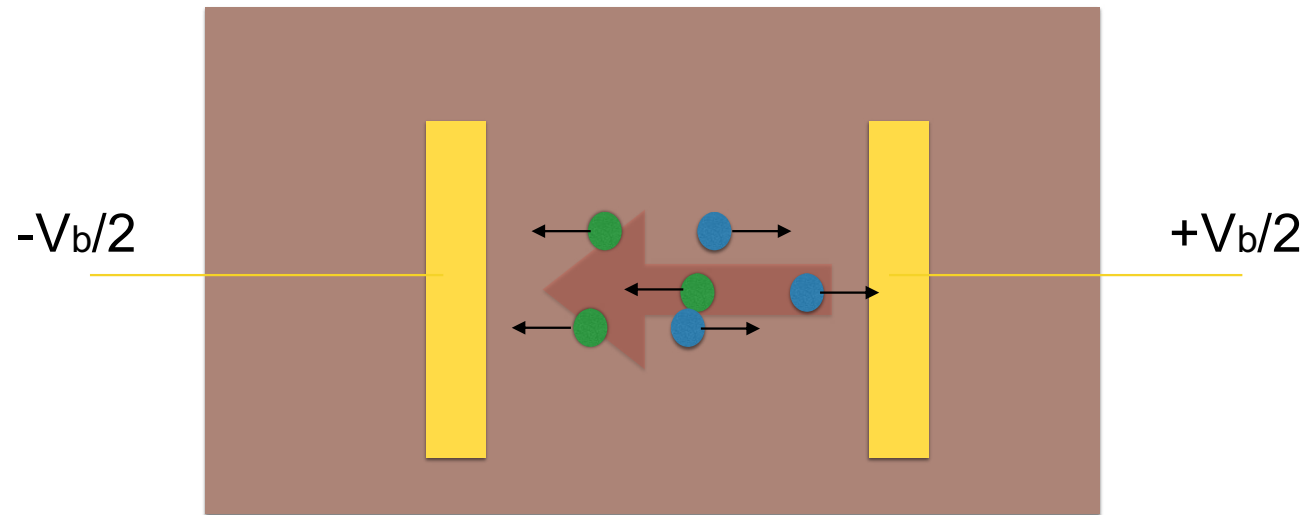
Laser pulse arrives, makes e-h pairs



Laser pulse arrives, makes e-h pairs



Electrons and holes see oppositely directed forces from bias field



Quickly brought to drift velocity, resulting in a current

Assume acceleration to drift velocity is fast

$$v_d = \mu E_b$$

“mobility” is proportionality constant between E-field and drift velocity

Also assume hole mobility is much smaller than electron mobility (often true)

$$J(t) = N(t)ev_d = N(t)e\mu E_b$$

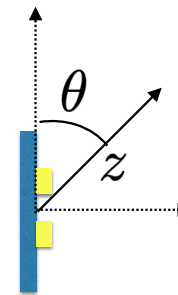
density of electrons

$$J(t) = N(t)ev_d = N(t)e\mu E_b$$

In the far field (i.e. several wavelengths away from antenna):

$$E_{THz} = \frac{1}{4\pi\epsilon_0} \frac{A}{c^2 z} \frac{\partial J(t)}{\partial t} \sin \theta$$

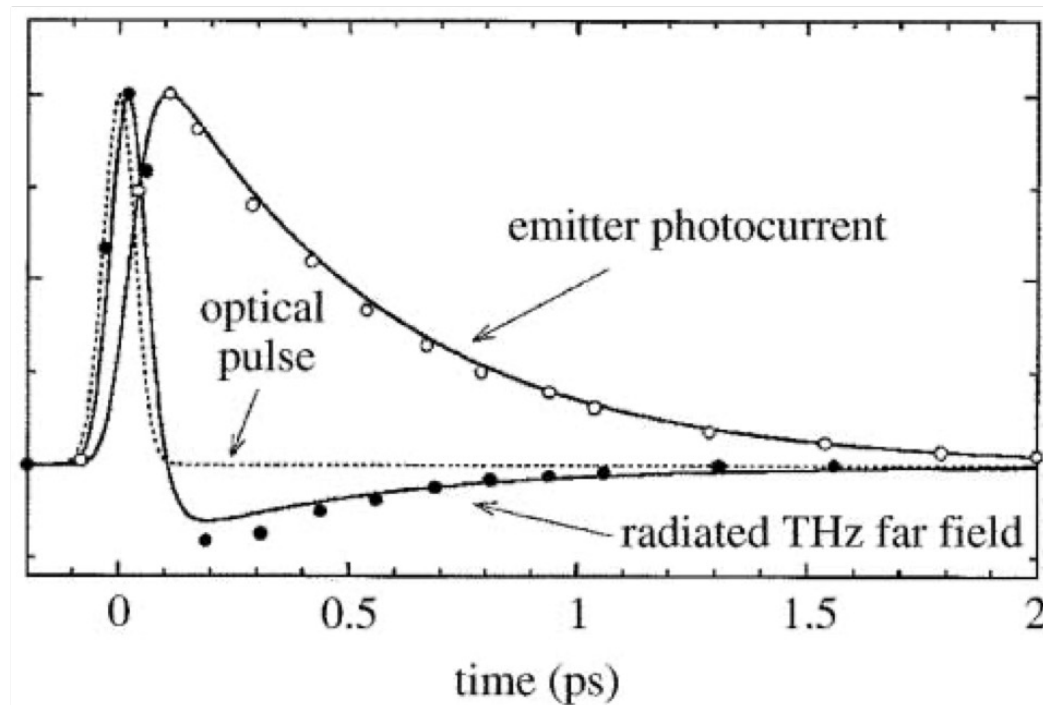
$A \equiv$ Illuminated gap area



For a complete derivation please refer to “Generation and Detection of Broadband Terahertz Pulses”, in Principles of Terahertz Science and Technology by Yun-Shik Lee - Springer (2009)

$$E_{THz} = \frac{Ae}{4\pi\epsilon_0 c^2 z} \frac{\partial N(t)}{\partial t} \mu E_b \sin \theta$$

Can also use the *decrease* in $N(t)$ to make THz



$$E_{THz} = \frac{Ae}{4\pi\epsilon_0 c^2 z} \frac{\partial N(t)}{\partial t} \mu E_b \sin \theta$$

Assumes “instantaneous” acceleration of electrons (holes)

Invalid on time scales comparable to
this acceleration time

Acceleration of carriers

$$\frac{1}{\gamma} = \frac{v_d m}{e E_b} = \frac{\mu m}{e}$$

Silicon at 300 K: $\frac{1}{\gamma} \approx 1$ ps !!!

LT-GaAs: $\frac{1}{\gamma} \sim 0.1$ ps

Difference is due to high mobility of Silicon

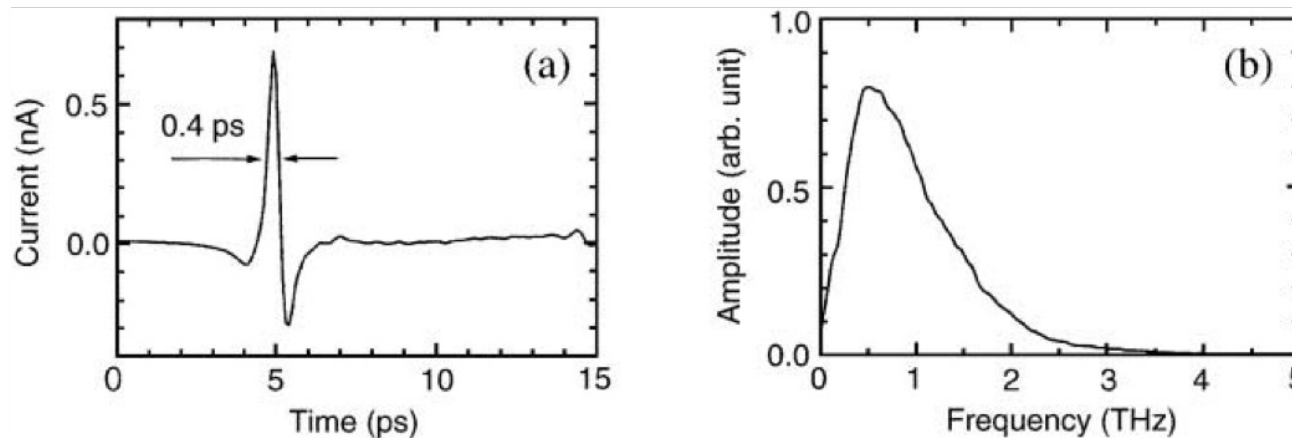
Inherent tension: higher mobility leads to slower transients, but higher currents \Rightarrow
For photoconductive switches low temperature grown GaAs is a better THz source

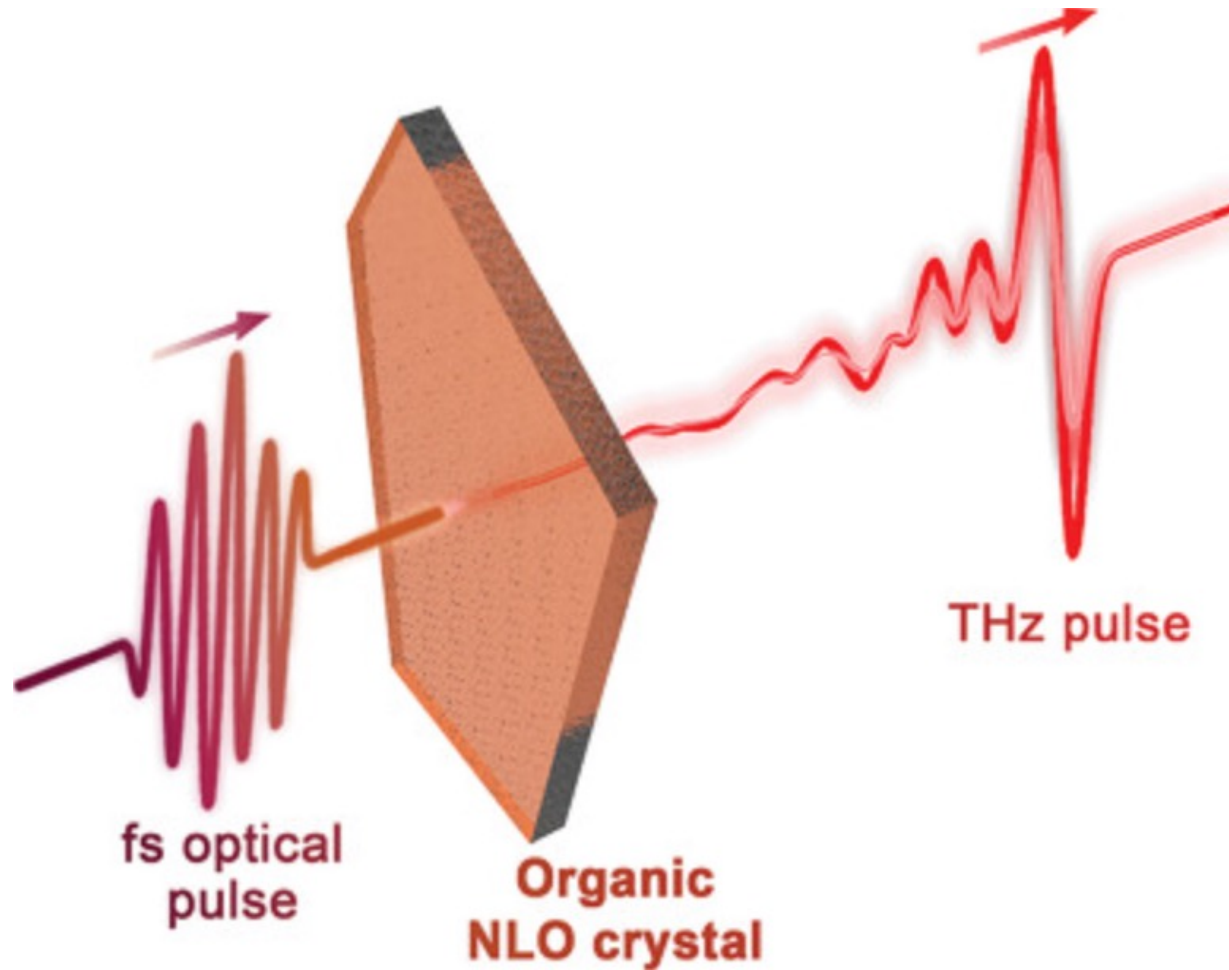
At low rep rates, can get up to $\sim 1 \mu\text{J}$

Usually limited peak fields ($< 10 \text{ kV/cm}$)

Broadband, single cycle, $\sim 1 \text{ THz}$ center freq.

Usually limited to rather low frequency region ($< 4 \text{ THz}$)



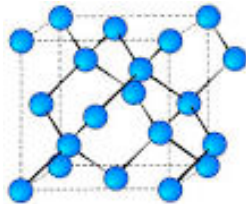


Kim, et al. *Adv. Optical Mater.* 2021, 9, 2101019

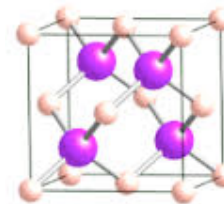


$$P_i(t) = \sum_j \chi_{ij}^{(1)} E_j(t) + \sum_{jk} \chi_{ijk}^{(2)} E_j(t) E_k(t) + \dots$$

zero in inversion-symmetric materials

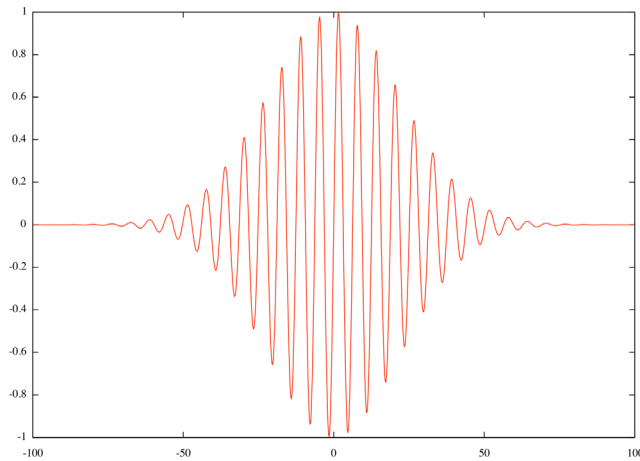
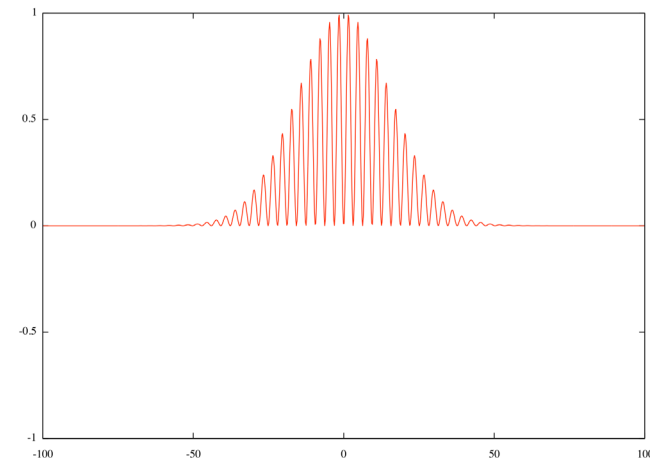


Diamond structure:
inversion symmetric
Diamond, Si, Ge,...

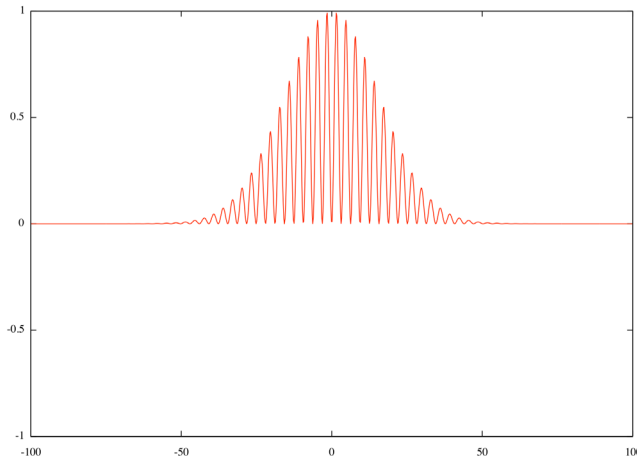


Zinc blende:
non-inversion symmetric
GaAs, InSb, ...

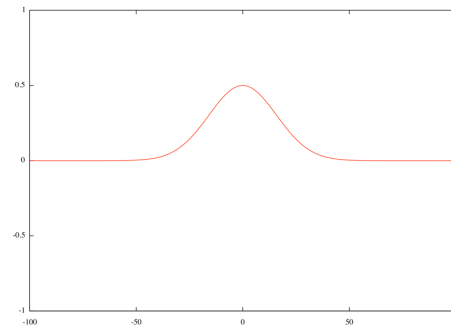
$$P_i(t) = \sum_j \chi_{ij}^{(1)} E_j(t) + \sum_{jk} \chi_{ijk}^{(2)} E_j(t) E_k(t) + \dots$$

 $E(t)$  $E^2(t)$ 

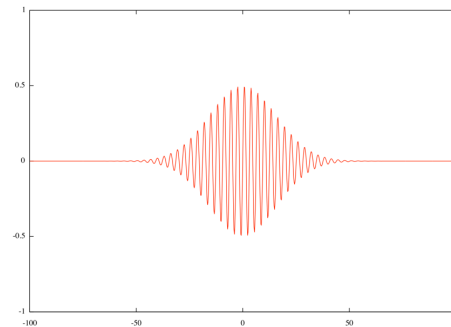
$$P_i(t) = \sum_j \chi_{ij}^{(1)} E_j(t) + \sum_{jk} \chi_{ijk}^{(2)} E_j(t) E_k(t) + \dots$$



=

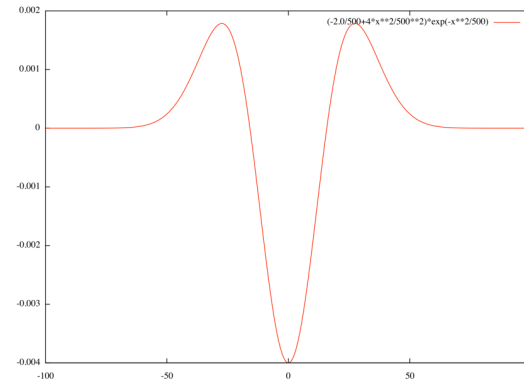
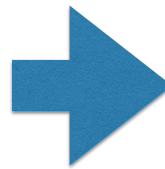
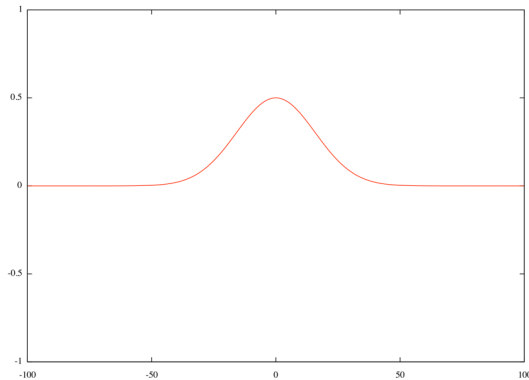


+

THz
(DFG)Second
harmonic
(SFG)

$$P_i(t) = \sum_j \chi_{ij}^{(1)} E_j(t) + \sum_{jk} \chi_{ijk}^{(2)} E_j(t) E_k(t) + \dots$$

Far field: $E_{THz} \sim \frac{\partial^2 P(t)}{\partial t^2}$



Process is equivalent to DFG mixing for wavelengths within wavepacket

For two frequencies, DFG phase matching conditions:

$$\omega_1 - \omega_2 = \Omega_{THz}$$

$$k_1 - k_2 = k_{THz}$$

$$\frac{\omega_1 - \omega_2}{k_1 - k_2} = \frac{\Omega_{THz}}{k_{THz}} \implies \frac{\partial \omega}{\partial k} = \frac{\Omega_{THz}}{k_{THz}}$$

$$\implies v_g(\text{pump}) = v_p(\text{THz})$$

Question: what happens if phase matching conditions satisfied but

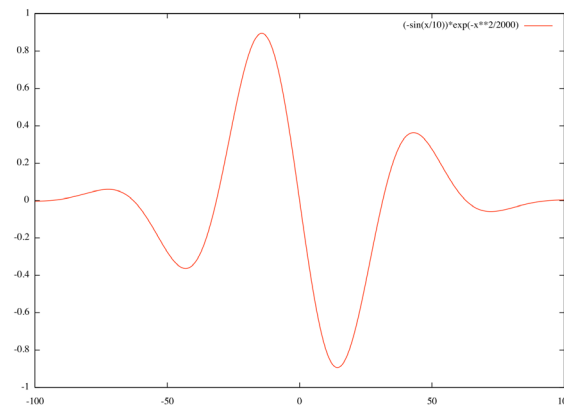
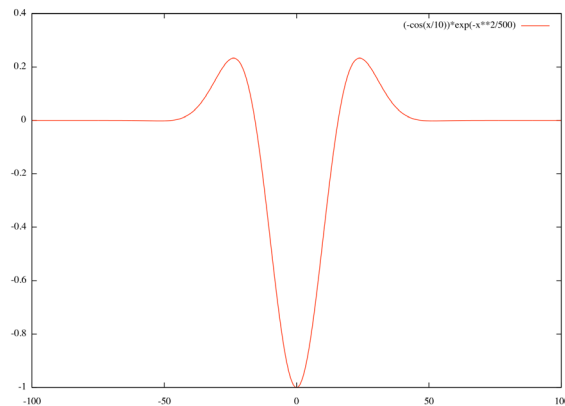
$$v_g(\text{pump}) \neq v_g(\text{THz}) ?$$

$$v_g(\text{pump}) \neq v_g(\text{THz})$$

$$v_g(\text{pump}) = v_p(\text{THz})$$

$$v_p(\text{THz}) \neq v_g(\text{THz})$$

carrier-envelope phase changes + pulse lengthens



$$\implies v_g(\text{pump}) = v_p(\text{THz})$$

“Accidentally” true in some materials:

ZnTe and GaP at 800 nm pump

DAST, OH1, DSTMS at ~ 1.5 microns pump

Possible using refractive index ellipse in GaSe at 800 nm

- Material must be transparent at both pump and THz wavelengths
- Material cannot possess a center of inversion symmetry
- Second-order susceptibility should be high
- Phase matching over all THz frequencies in pulse (need low dispersion of permittivity); phonons will limit this

$$\text{ZnTe: } \omega_{TO} \approx 5 \text{ THz}$$

$$\text{GaP: } \omega_{TO} \approx 11 \text{ THz}$$

Inorganic compounds

- Cheap and resilient materials
- Mostly transparent for >600 nm
- Sustain high optical pumping intensity
- Phase matched at 800 nm / 1 μ m (central wavelength of commercial Ti:Sa and finer lasers)
- Two-photon absorption
- Limited nonlinear tensor χ^2

Typical THz fields : 10-40 kV/cm

Typical BW: up to 8 THz (material dependent)

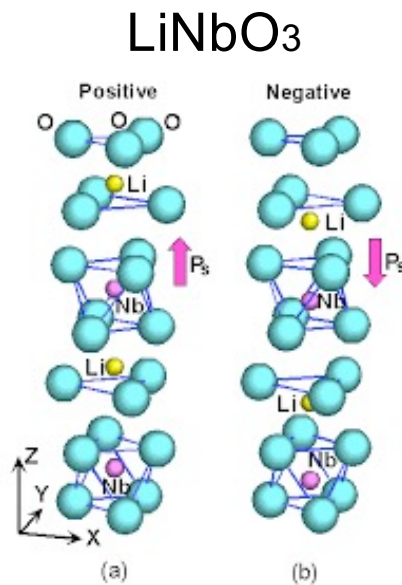
Organic compounds

- NOT Cheap and NOT resilient
- Sustain limited optical intensity
- Mostly transparent for >1200 nm (OPA needed)
- Phase matched >1.2 μ m
- Large nonlinear tensor χ^2

Typical THz fields : >300 kV/cm

Typical BW: up to 8 THz. Usually low frequency phonon present: efficient emitters >1.5 THz (material dependent)

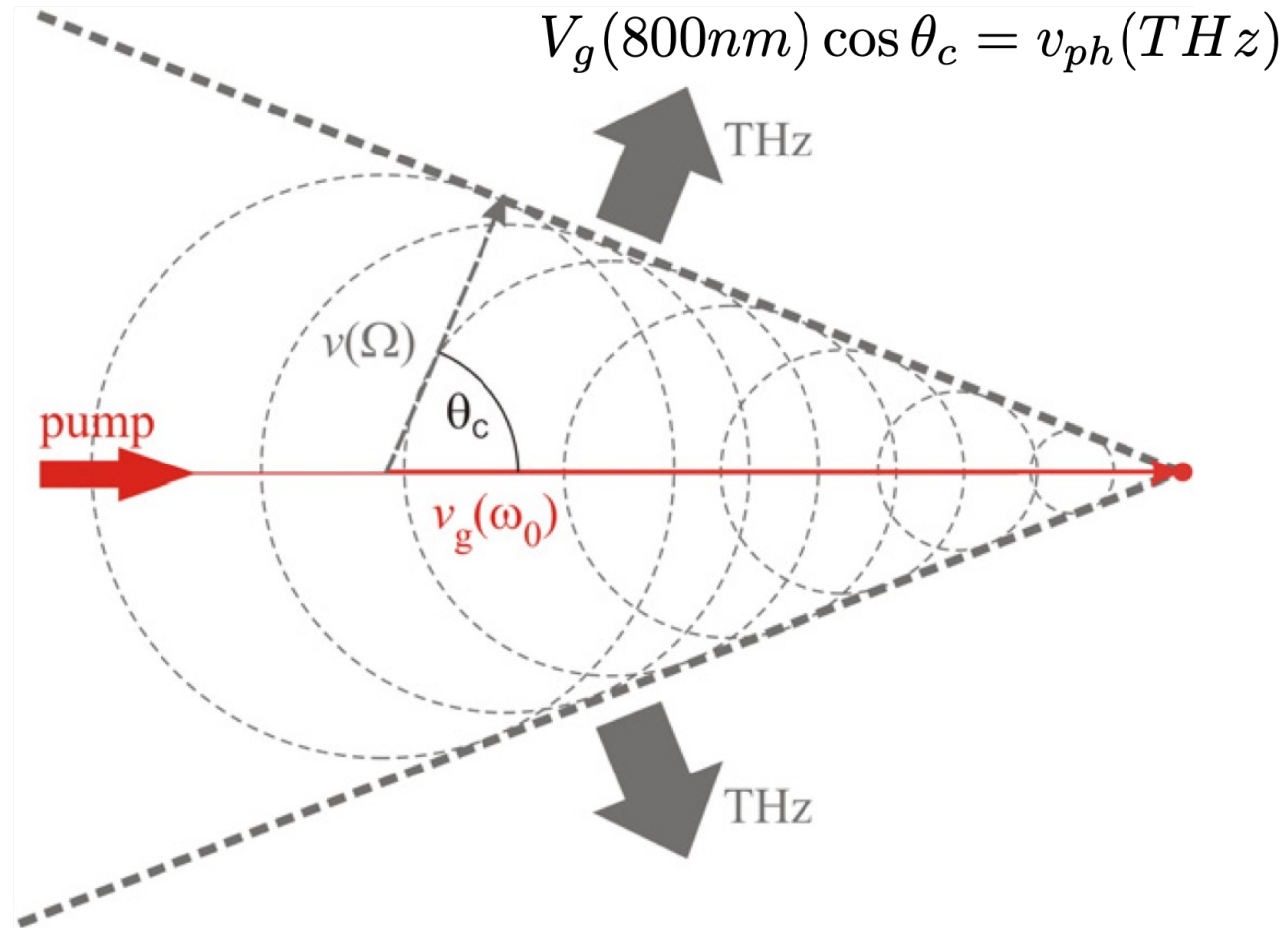
Tilted pulse front



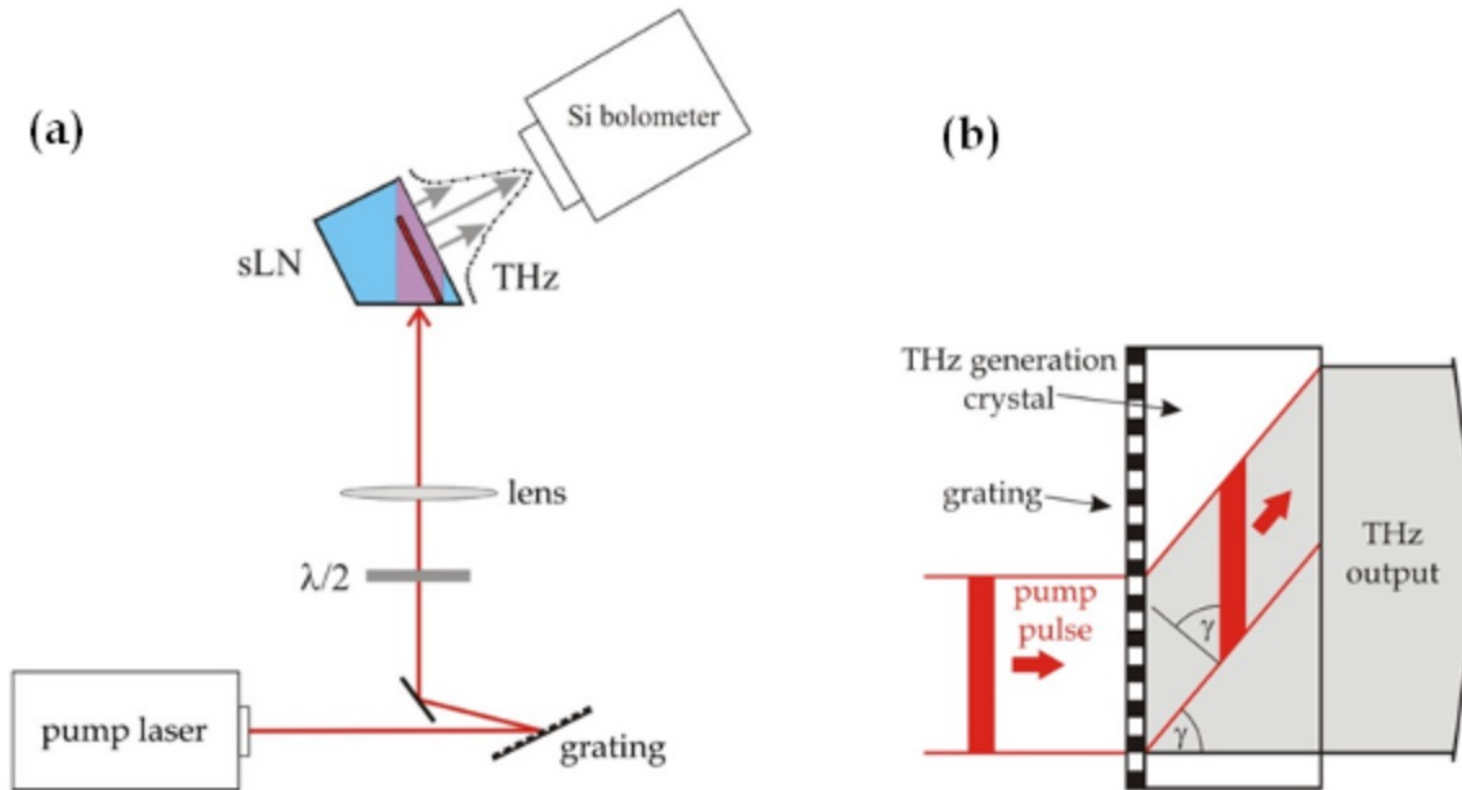
Good: robust, transparent, reasonable nonlinear coefficient

Bad: $v_{ph}(THz) \ll v_g(800nm)$
(mismatch by about a factor of 2)

Tilted pulse front



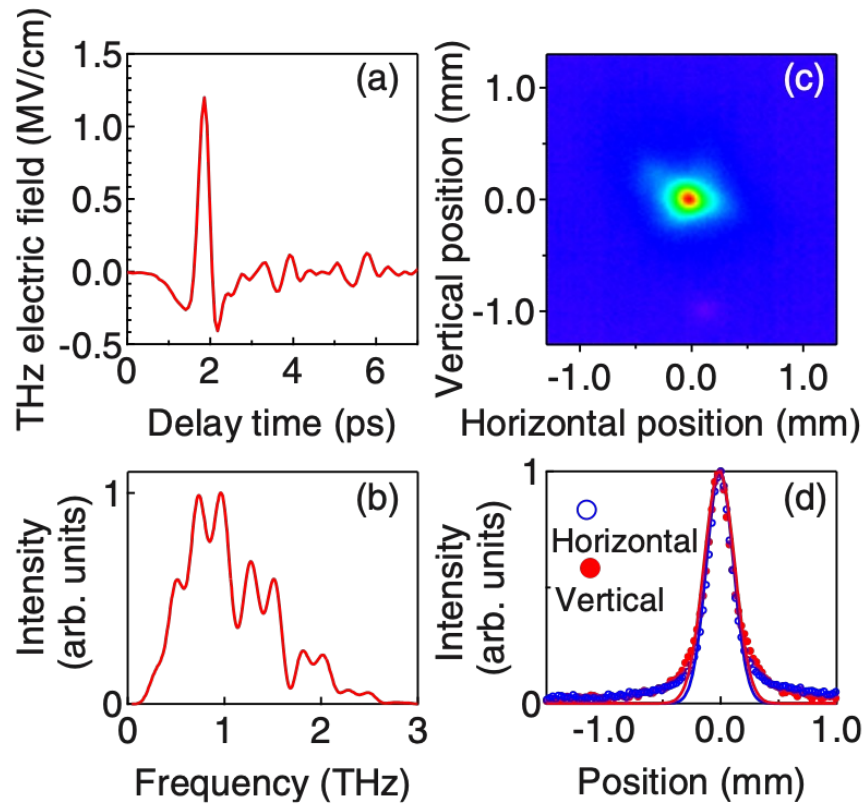
Tilted pulse front, via gratings



Fülöp, et al. Applications of Tilted-Pulse-Front Excitation, in *Recent Optical and Photonic Technologies*, IntechOpen 2010

Single-cycle terahertz pulses with amplitudes exceeding 1 MV/cm generated by optical rectification in LiNbO₃

H. Hirori, A. Doi, F. Blanchard, and K. Tanaka

Citation: *Applied Physics Letters* **98**, 091106 (2011); doi: 10.1063/1.3560062

Nowadays >1 MV/cm routinely achieved
Rather limited BW (<2THz)

- By far the most expensive option, by many orders of magnitude
- Delivers the brightest pulses

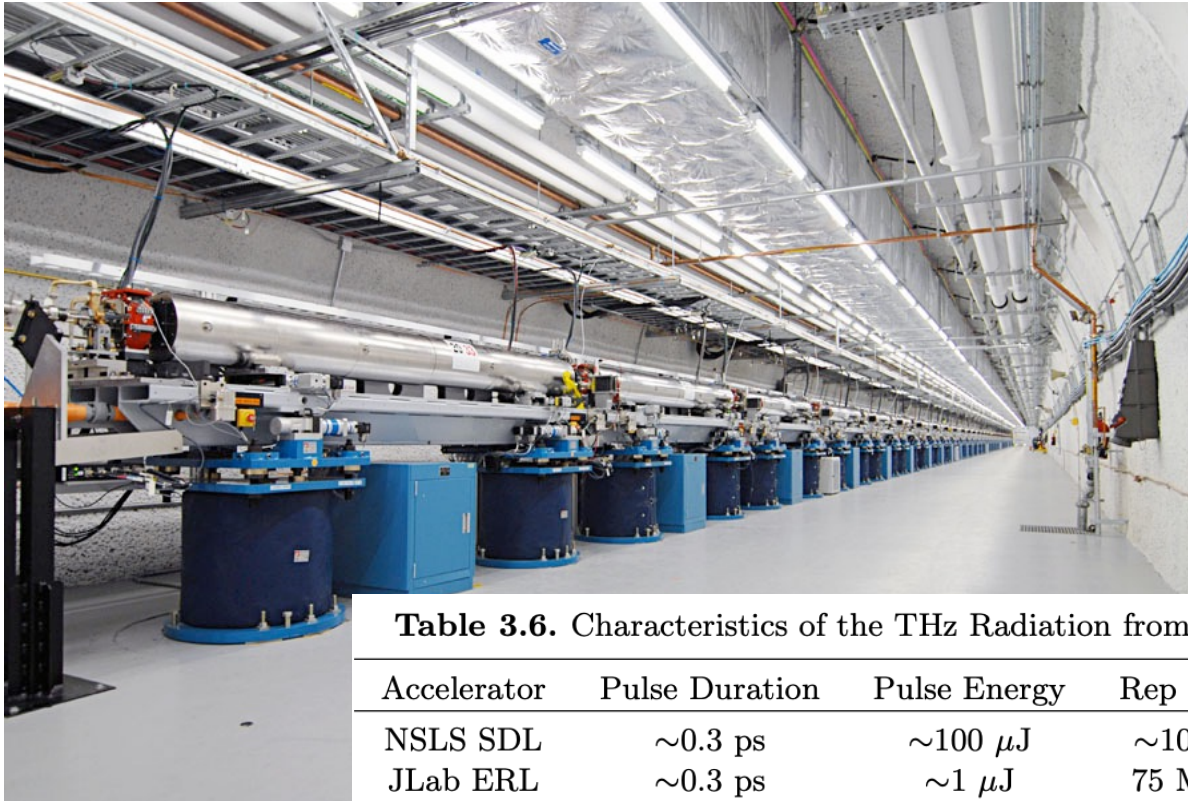


Table 3.6. Characteristics of the THz Radiation from Electron Accelerators

Accelerator	Pulse Duration	Pulse Energy	Rep Rate	Average Power
NSLS SDL	~ 0.3 ps	~ 100 μ J	~ 10 Hz	~ 1 mW
JLab ERL	~ 0.3 ps	~ 1 μ J	75 MHz	~ 20 W
BESSY	~ 1 ps	~ 1 nJ	500 MHz	~ 1 W

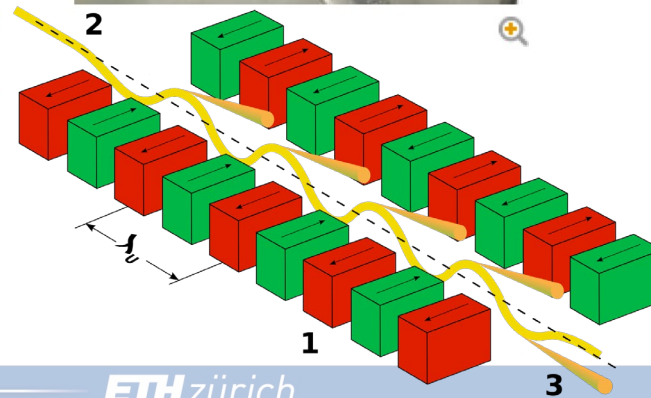
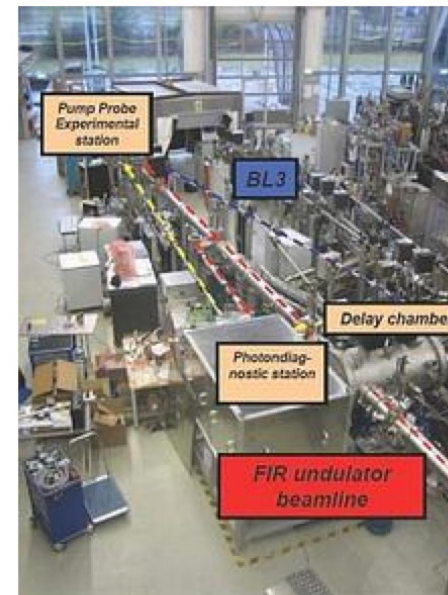
(from Lee, Ch.3 "Terahertz Radiation from Electron Accelerators")

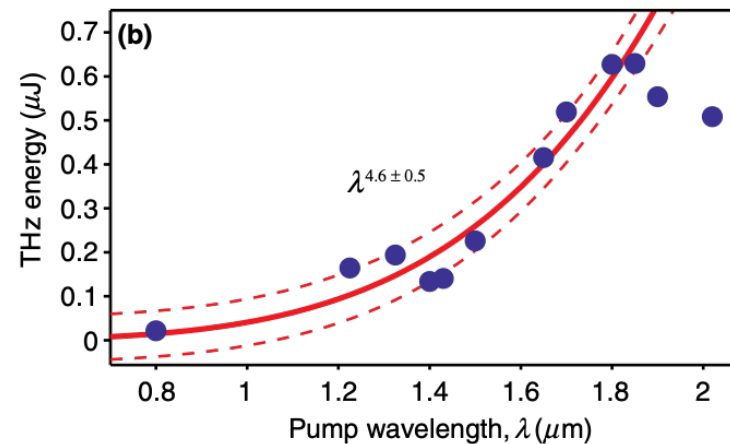
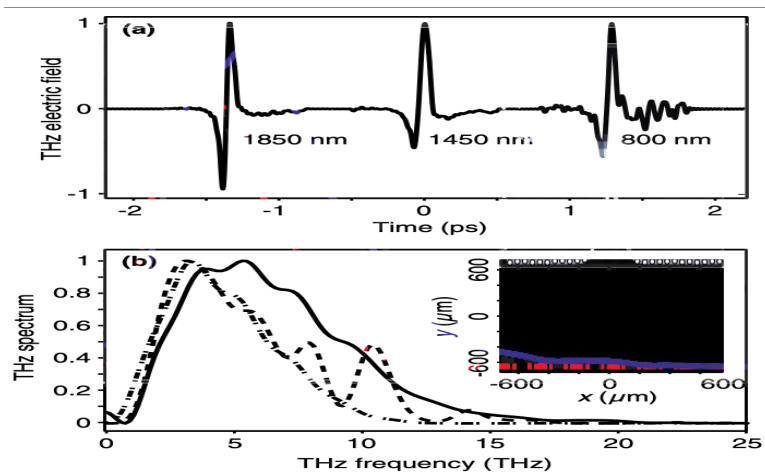
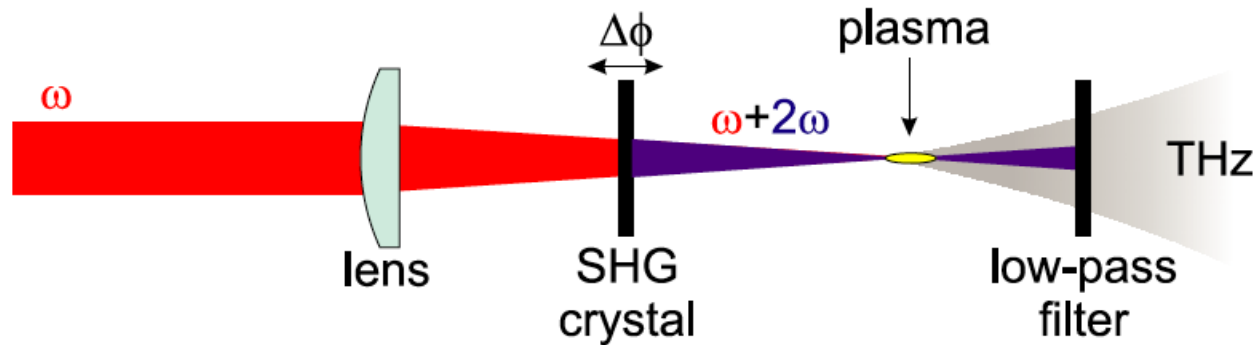
THz Undulator Beamline @ BL3

The THz undulator beamline has been designed to provide coherent femtosecond (fs) – picosecond (ps) THz pulses for pump-and-probe experiments with the fs VUV pulses from FLASH. First light has been delivered into the experimental hall in November 2007. The THz pulses are generated by a purpose built undulator implemented in series to the VUV undulators. The design of the beamline allows to overlap a VUV pulse and a THz pulse generated by the same electron bunch at the end of BL3. The pulses should therefore be naturally synchronized. The expected pulse energies lie within the microjoule regime.

THz radiation with the following parameters is available for pump-and-probe experiments at BL3:

- tunable: 10–230 μm ; up to 100 $\mu\text{J}/\text{pulse}$; $\sim 10\%$ bandwidth,
- broadband at 200 μm , up to 10 $\mu\text{J}/\text{pulse}$; $\sim 100\%$ bandwidth
- synchronized and phase stable to X-ray pulses (down to 5 fs)
- delivered to the experiment via vacuum beamline as:
 - (i) ultra-high vacuum ($\sim 10^{-8}$ mbar), shorter delay between THz and X-ray (~ 4 m path difference), can accommodate up to 0.3 m wide setup;
 - (ii) high vacuum (pressure $\sim 10^{-6}$ mbar), longer delay between THz and X-ray (~ 7 m path difference); can accommodate up to 2 m wide setup



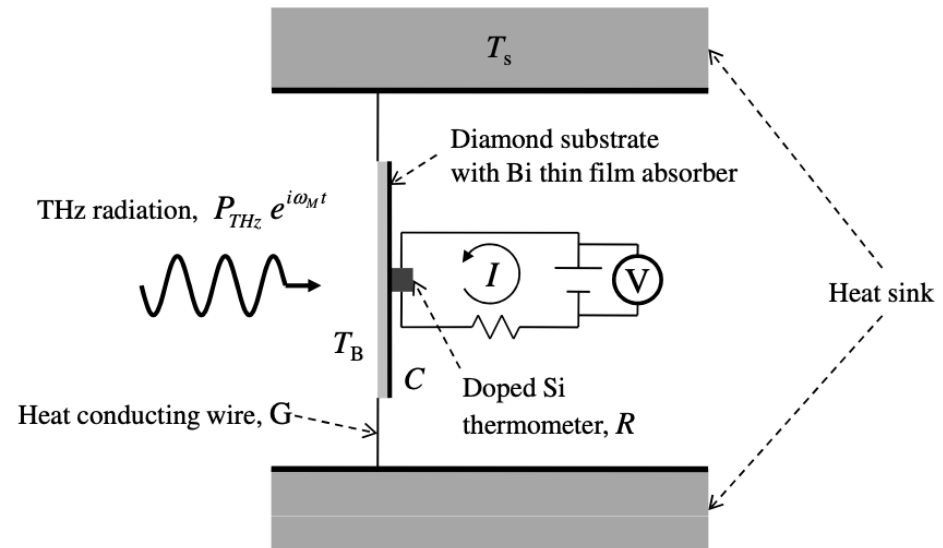


THz E-fields as large as 4 MV/cm, extremely broad BW (up to 15/20 THz)...
 ... but rather noisy/unstable, due to the intrinsic chaotic generation process

Two main types:

- Thermal detectors
 - Absorb photons, detect change in T
- Phase sensitive
 - Rely on electric-field induced changes in some material

- Absorb THz photons in reservoir that is inefficiently thermally coupled to environment
- Measure ΔT
- Advantage: fairly flat spectral response (depends on absorber)
- Disadvantage: slow, sometimes needs cooling



- Measure electric field vs. time
- As name suggests, gives phase information that is lost in thermal detection
- Most examples of phase sensitive detectors look like pulse generators operated “in reverse”:
 - Photoswitches
 - EO sampling
 - ABCD detection

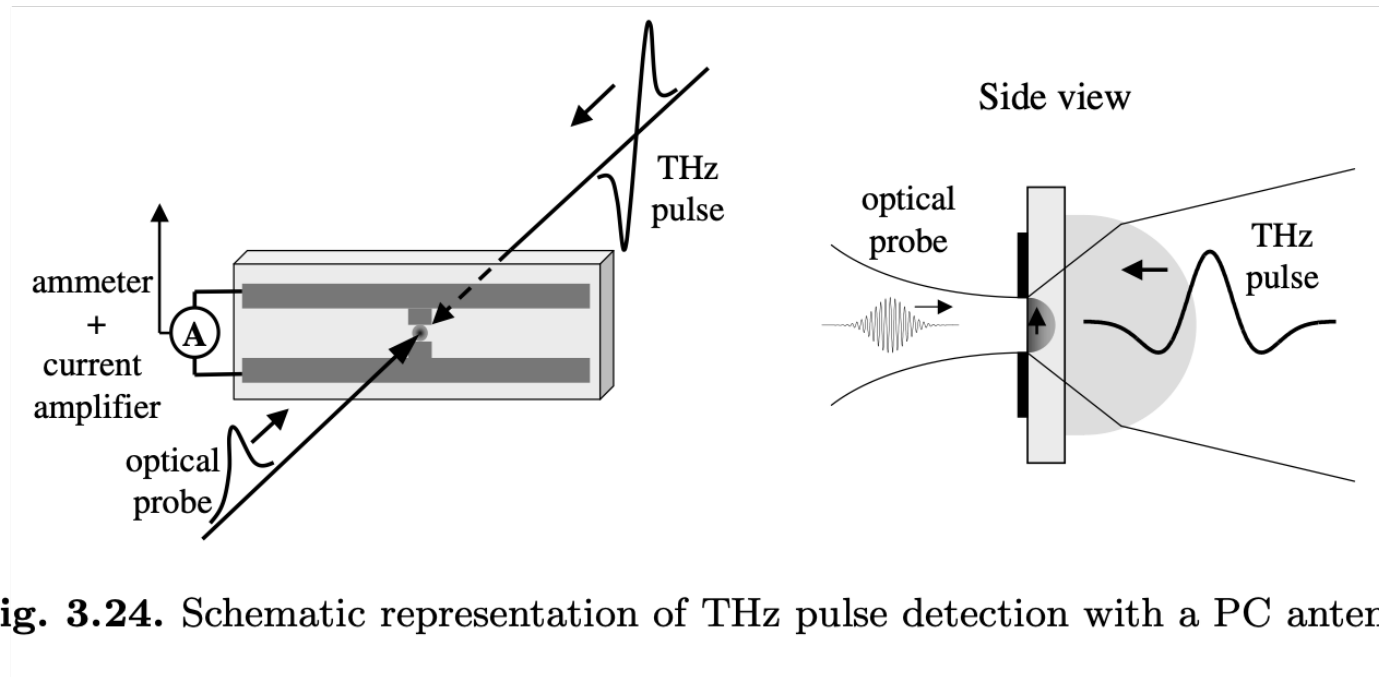


Fig. 3.24. Schematic representation of THz pulse detection with a PC antenna

- Measure E-field via current across antenna
- Similar bandwidth limitations as generator

Electro-optic effect: modulation of the refractive index (dielectric constant) via application of an external (slowly-varying) E-field

$$\epsilon_{ij} = \delta_{ij} + \chi_{ijk}^{(2)} E_k$$

(only possible in materials without inversion symmetry)

- Applied E-field changes dielectric tensor
- New tensor may have different symmetry
- Can measure changes to dielectric tensor induced by THz field using higher frequency light (e.g. 800 nm)

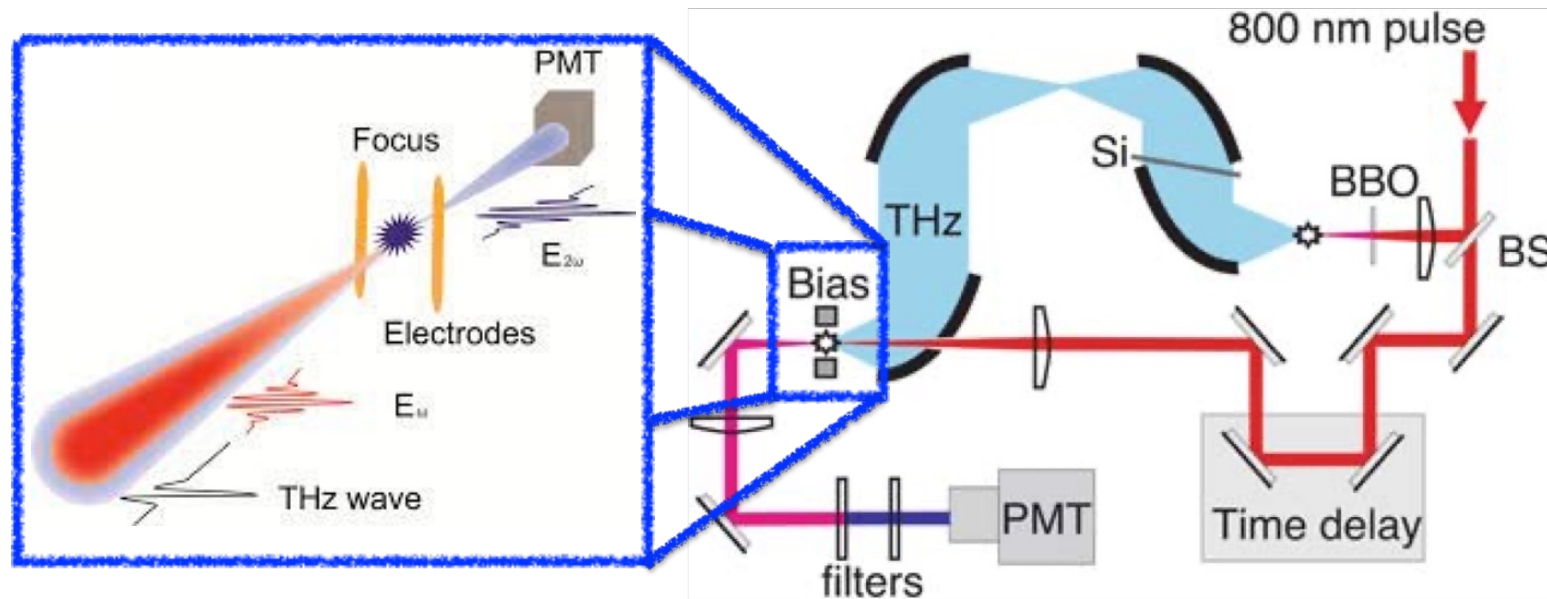
$$n_x = \sqrt{1 + a + cE_0}$$

$$n_y = \sqrt{1 + a - cE_0}$$

$$E_{opt}^{(in)} = \frac{1}{\sqrt{2}} \begin{pmatrix} 1 \\ 1 \\ 0 \end{pmatrix} \longrightarrow E_{opt}^{(out)} = \frac{1}{\sqrt{2}} \begin{pmatrix} e^{ikDn_x} \\ e^{ikDn_y} \\ 0 \end{pmatrix}$$

phase difference of DcE_0 ...beam becomes slightly elliptical

- Four Wave Mixing effect where the THz E-field is used as bias on gas
- Uses third order susceptibility to generate SHG
- Very broad bandwidth, but more noisy than other methods



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